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DEC 23n20the united states patent and trademark office Technology center 2800

Application of

Akira YONEZAWA

Serial No. 09/978,258 : Group Art Unit - 2832

Filed: October 15, 2001 : F

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For: ELECTROMAGNETIC FIELD

JUL 0 3 2003

SUPERIMPOSED LENS AND ELECTRON BEAM DEVICE

Technology Center 2600

USING THIS ELECTRO-

MAGNETIC FILED SUPER-

IMPOSED LENS : Docket No. S004-4416

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COMMISSIONER OF PATENTS AND TRADEMARKS Washington, DC 20231

PRELIMINARY AMENDMENT

SIR:

In order to place this application in better condition for a complete examination on the merits, applicant preliminarily amends his application as follows:

IN THE SPECIFICATION:

Please replace the paragraph beginning at page 1, line 8, with the following rewritten paragraph:

A (

--In order to perform inspection or observation of the shape of a fine pattern using an electron beam device,

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12/19/2002 NHOHAHH1

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MAILING CERTIFICATE ON LAST PAGE